

# TEST REPORT No. I17Z61084-EMC05

for

Lenovo(Shanghai) Electronics Technology Co., Ltd.

**Portable Tablet Computer** 

Model Name: Lenovo TB-7504X

with

**FCC ID: 057TB7504X** 

Hardware Version: Lenovo Tablet TB-7504X

Software Version: TB-7504X\_RF01\_170712

Issued Date: 2017-08-03



#### Note:

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#### **Test Laboratory:**

CTTL, Telecommunication Technology Labs, CAICT

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## **REPORT HISTORY**

Report Number	Revision	Description	Issue Date
I17Z61084-EMC05	Rev.0	1 <sup>st</sup> edition	2017-08-03



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## 1. Test Laboratory

### 1.1. Testing Location

**Location: CTTL(huayuan North Road)** 

Address: No. 52, Huayuan North Road, Haidian District, Beijing, P. R. China

100191

1.2. Testing Environment

Normal Temperature: 15-35°C Relative Humidity: 20-75%

1.3. Project data

Testing Start Date: 2017-07-16
Testing End Date: 2017-07-31

1.4. Signature

Wang Junqing

(Prepared this test report)

张 颖

Zhang Ying (Reviewed this test report)

Liu Baodian

**Deputy Director of the laboratory** 

(Approved this test report)



Address /Post:

## 2. Client Information

#### 2.1. Applicant Information

Company Name: Lenovo(Shanghai) Electronics Technology Co., Ltd.

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City: Shanghai
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 +86-21-50504500-8281

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#### 2.2. Manufacturer Information

Company Name: Lenovo PC HK Limited

23/F, Lincoln House, Taikoo Place

Address /Post: 979 King's Road, Quarry Bay, Hong Kong

City: Shanghai
Postal Code: 201203
Country: P. R. China
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## 3. Equipment Under Test (EUT) and Ancillary Equipment (AE)

#### 3.1. About EUT

Description Portable Tablet Computer

Model Name Lenovo TB-7504X FCC ID O57TB7504X Marketing Name Lenovo TAB 7

Extreme vol. Limits 3.5VDC to 4.3VDC (nominal: 3.85VDC)

Note: Components list, please refer to documents of the manufacturer; it is also included in the original test record of CTTL, Telecommunication Technology Labs, Academy of Telecommunication Research, MIIT.

#### 3.2. Internal Identification of EUT used during the test

EUT ID*	SN or IMEI	HW Version	SW Version
EUT1	865596030018676/	Lenovo Tablet TB-7504X	TB-7504X_RF01_170712
LUII	865596030018684		

<sup>\*</sup>EUT ID: is used to identify the test sample in the lab internally.

#### 3.3. Internal Identification of AE used during the test

3.3. <u>Inte</u>	mai identifica	tion of AE used during	<u>ine test</u>
AE ID*	Description	SN	Remarks
AE1	Battery	/	/
AE2	Battery	/	/
AE3	Charger	1	/
AE4	Charger	/	/
AE14	USB Cable	1	/
AE15	USB Cable	/	/
AE1			
Model		SB18C15123	
Manufac	turer	Sunwoda	
Capacita	nce	3500mAh	
Nominal	voltage	3.85V	
AE2			
Model		SB18C15124	
Manufac	turer	SCUD	
Capacita	nce	3500mAh	
Nominal	voltage	3.85V	
AE3			
Model		C-P56	
Manufac	turer	Huntkey	
Length of	f cable	/	
AE4			
Model		C-P57	
Manufac	turer	Acbel	
Length of	f cable	/	



AE14

Model SWT-A064A

Manufacturer Saibao Length of cable 80cm

AE15

Model WT59B1000100 Manufacturer Fukangyuan

Length of cable 80cm

\*AE ID: is used to identify the test sample in the lab internally.

Note: The USB cables are shielded.



## 3.4. EUT set-ups

EUT set-up No.	Combination of EUT and AE	Remarks
Set.17	EUT1+ AE3+ AE11/AE12	Charger
Set.23	EUT1+ AE4+ AE11/AE12	Charger
Set.25	EUT1+ AE11	USB



## 4. Reference Documents

### 4.1. Reference Documents for testing

The following documents listed in this section are referred for testing.

Reference	Title	Version
FCC Part 15, Subpart B	Radio frequency devices - Unintentional Radiators	2016
ANSI C63.4	American National Standard for	2014
	Methods of Measurement of Radio-	
	Noise Emissions from Low-Voltage	
	Electrical and Electronic Equipment	
	in the Range of 9 kHz to 40 GHz	
1056 003	Information Technology Equipment(ITE)-Limits and	looue 6
ICES-003	methods of measurement	Issue 6

Note: The test methods have no deviation with standards.



## 5. LABORATORY ENVIRONMENT

**Semi-anechoic chamber SAC-1** (23 meters×17meters×10meters) did not exceed following limits along the EMC testing:

in the dietig the Line teeting.	
Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. = 15 %, Max. = 75 %
Shielding effectiveness	0.014MHz-1MHz, >60dB;
	1MHz - 1000MHz, >90dB.
Electrical insulation	> 2 M
Ground system resistance	< 4
Normalised site attenuation (NSA)	< ±4 dB, 10 m distance
Site voltage standing-wave ratio (S <sub>VSWR</sub> )	Between 0 and 6 dB, from 1GHz to 6GHz
Uniformity of field strength	Between 0 and 6 dB, from 80 to 3000 MHz

**Shielded room** did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. = 20 %, Max. = 75 %
Shielding effectiveness	0.014MHz-1MHz, >60dB;
	1MHz-1000MHz, >90dB.
Electrical insulation	> 2 M
Ground system resistance	< 4



## 6. SUMMARY OF TEST RESULTS

Abbreviations used in this clause:		
Р		Pass
Verdict Column	NA	Not applicable
F		Fail
Location Column huayuan North Road		The test is performed in test location huayuan North
		Road which is described in section 1.1 of this report

Items	Test Name	Clause in FCC rules	Section in this report	Verdict	Test Location
1	Radiated Emission	15.109(a)	B.1	Р	1
2	Conducted Emission	15.107(a)	B.2	Р	1



## 7. Test Equipments Utilized

NO.	Description	TYPE	SERIES NUMBER	MANUFACTURE	CAL DUE DATE	CALIBRATI ON INTERVAL
1	Test Receiver	ESU26	100235	R&S	2018-03-01	1 year
2	Test Receiver	ESCI 7	100344	R&S	2018-03-15	1 year
3	Universal Radio Communication Tester	CMW500	143008	R&S	2017-12-01	1 year
4	Universal Radio Communication Tester	CMW500	155415	R&S	2018-02-15	1 year
5	LISN	ENV216	101200	R&S	2018-08-03	1 year
6	EMI Antenna	VULB 9163	9163-301	Schwarzbeck	2017-12-16	3 years
7	EMI Antenna	3115	6914	ETS-Lindgren	2017-12-15	3 years
8	PC	OPTIPLEX 380	2X1YV2X	DELL	N/A	N/A
9	Printer	P1606dn	VNC3L52122	HP	N/A	N/A
10	Keyboard	L100	CN0RH6596589 07ATOI40	DELL	N/A	N/A
11	Mouse	M-UAE119	LZ935220ZRC	Lenovo	N/A	N/A

Test Item	Test Software and Version	Software Vendor
Radiated Continuous Emission	EMC32 V9.01	R&S
Conducted Emission	EMC32 V8.52.0	R&S



### **ANNEX A: MEASUREMENT RESULTS**

#### A.1 Radiated Emission

#### Reference

FCC: CFR Part 15.109(a). IC: ICES-003 Section 5.

#### A.1.1 Method of measurement

The field strength of radiated emissions from the unintentional radiator (charging mode of MS) at distances of 3 meters(for 30MHz-1GHz) and 3 meters (for above 1GHz) is tested. Tested in accordance with the procedures of ANSI C63.4 – 2014, section 8.3.

The EUT was placed on a non-conductive table. The measurement antenna was placed at a distance of 3/10 meters from the EUT. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations.

#### A.1.2 EUT Operating Mode:

The MS is operating in the charging mode. During the test MS is connected to a charger in the case of charging mode.

Note: I/O information: Printer – USB, Mouse – PS/2, Keyboard – USB.

#### A.1.3 Measurement Limit

Frequency range	Field strength limit (μV/m)					
(MHz)	Quasi-peak	Average	Peak			
30-88	100					
88-216	150					
216-960	200					
960-1000	500					
>1000		500	5000			

Note: the above limit is for 3 meters test distance. 10 meters' limit is got by converting.

#### A.1.4 Test Condition

Frequency range (MHz)	RBW/VBW	Sweep Time (s)	Detector
30-1000	120kHz (IF Bandwidth)	5	Peak/Quasi-peak
Above 1000	1MHz/1MHz	15	Peak, Average



#### A.1.5 Measurement Results

A "reference path loss" is established and the  $A_{Rpl}$  is the attenuation of "reference path loss". It includes the antenna factor of receive antenna and the path loss.

The measurement results are obtained as described below:

Result =  $P_{Mea} + A_{Rpl} = P_{Mea} + G_A + G_{PL}$ 

Where

GA: Antenna factor of receive antenna

G<sub>PL</sub>: Path Loss

P<sub>Mea</sub>: Measurement result on receiver.

Measurement uncertainty (worst case): 30MHz-1GHz: 4.86dB, 1GHz-18GHz: 5.26dB, k=2.

#### **Measurement results for Set.17**:

#### **Charging Mode/Average detector**

Frequency(MHz)	Result(dB <sub>μ</sub> V/m)	G <sub>PL</sub> (dB)	G <sub>A</sub> (dB/m)	P <sub>Mea</sub> (dBµV)	Polarity
17938.233	43.7	-17.7	45.6	15.800	Н
17911.600	43.6	-18.5	45.6	16.500	Н
17934.833	43.5	-17.7	45.6	15.600	Н
17957.500	43.5	-17.7	45.6	15.600	V
17964.300	43.4	-17.7	45.6	15.500	V
17947.867	43.4	-17.7	45.6	15.500	Н

#### **Charging Mode/Peak detector**

Frequency(MHz)	Result(dBμV/m)	G <sub>PL</sub> (dB)	G <sub>A</sub> (dB/m)	$P_{Mea}(dB\mu V)$	Polarity
18000.000	53.2	-45.6	44.5	54.266	Н
17999.433	52.9	-17.7	45.6	25.000	V
17998.867	53.6	-17.7	45.6	25.700	V
17998.300	52.6	-17.7	45.6	24.700	V
17997.733	53.9	-17.7	45.6	26.000	V
17997.167	53.4	-17.7	45.6	25.500	Н

Sample calculation: Peak detector, 17997.167MHz

Result = $P_{Mea}$  (25.5dB $\mu$ V)+  $G_A$  (45.6dB/m)+  $G_{PL}$ (-17.7 dB) =53.4dB $\mu$ V/m

#### Measurement results for Set.23:

#### **Charging Mode/Average detector**

Frequency(MHz)	Result(dB <sub>μ</sub> V/m)	G <sub>PL</sub> (dB)	G <sub>A</sub> (dB/m)	$P_{Mea}(dB\mu V)$	Polarity
17959.200	43.8	-17.7	45.6	15.900	Н
17969.967	43.7	-17.7	45.6	15.800	Н
17930.300	43.7	-17.7	45.6	15.800	Н
17911.033	43.6	-18.5	45.6	16.500	Н
17905.367	43.6	-18.5	45.6	16.500	Н
17928.600	43.6	-17.7	45.6	15.700	Н



#### **Charging Mode/Peak detector**

Frequency(MHz)	Result(dB <sub>μ</sub> V/m)	G <sub>PL</sub> (dB)	G <sub>A</sub> (dB/m)	$P_{Mea}(dB\mu V)$	Polarity
17960.333	55.8	-17.7	45.6	27.900	Н
17956.933	55.6	-17.7	45.6	27.700	Н
17958.067	55.0	-17.7	45.6	27.100	Н
17954.100	54.8	-17.7	45.6	26.900	Н
17975.633	54.8	-17.7	45.6	26.900	Н
17739.333	54.8	-18.5	45.6	27.700	Н

Sample calculation: Peak detector, 17739.333MHz

Result = $P_{Mea}$  (27.7dB $\mu$ V)+  $G_A$  (45.6dB/m)+  $G_{PL}$ (-18.5 dB) =54.8dB $\mu$ V/m

#### Measurement results for Set.25:

#### **USB Mode/Average detector**

Frequency(MHz)	Result(dB <sub>μ</sub> V/m)	G <sub>PL</sub> (dB)	G <sub>A</sub> (dB/m)	$P_{Mea}(dB\mu V)$	Polarity
17941.067	43.7	-17.7	45.6	15.800	Н
17949.000	43.7	-17.7	45.6	15.800	V
17928.600	43.6	-17.7	45.6	15.700	V
17934.833	43.6	-17.7	45.6	15.700	Н
17947.867	43.5	-17.7	45.6	15.600	Н
17861.167	43.5	-18.5	45.6	16.400	V

#### **USB Mode/Peak detector**

Frequency(MHz)	Result(dB <sub>μ</sub> V/m)	G <sub>PL</sub> (dB)	G <sub>A</sub> (dB/m)	P <sub>Mea</sub> (dBµV)	Polarity
17849.833	55.4	-18.5	45.6	28.300	V
17841.333	55.2	-18.5	45.6	28.100	V
17938.233	55.1	-17.7	45.6	27.200	Н
17980.167	55.0	-17.7	45.6	27.100	V
17917.267	54.8	-17.7	45.6	26.900	Н
17939.933	54.7	-17.7	45.6	26.800	V

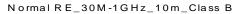
Sample calculation: Peak detector, 17939.933MHz

Result = $P_{Mea}$  (26.8dB $\mu$ V)+  $G_A$  (45.6dB/m)+  $G_{PL}$ (-17.7 dB) =54.7dB $\mu$ V/m

Note: The measurement results of Set.17, Set.23 and Set.25 showed here are worst cases of the combinations of different batteries and USB cables.



#### **Charging Mode, Set.17**



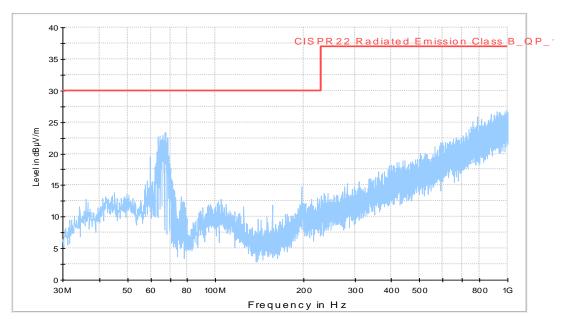
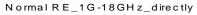


Figure A.1 Radiated Emission from 30MHz to 1GHz



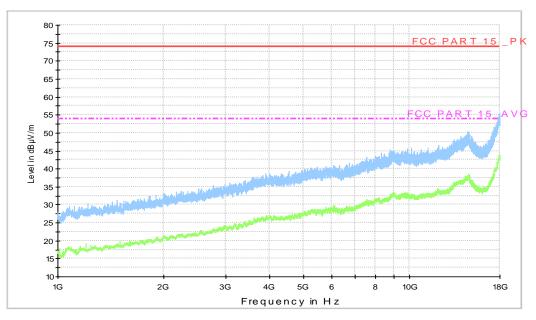


Figure A.2 Radiated Emission from 1GHz to 18GHz



#### **Charging Mode, Set.23**



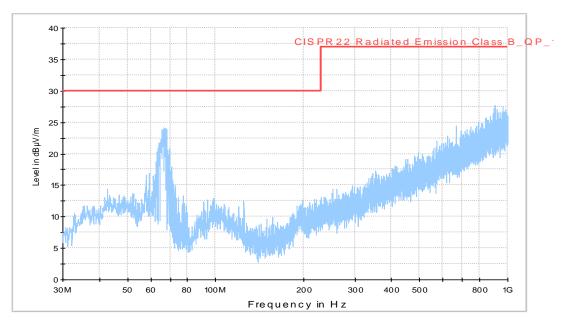
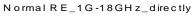


Figure A.3 Radiated Emission from 30MHz to 1GHz



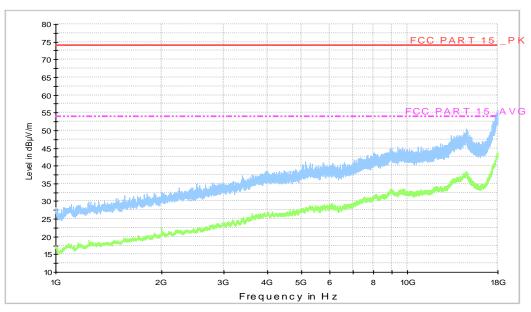
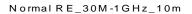


Figure A.4 Radiated Emission from 1GHz to 18GHz



#### **USB Mode, Set.25**



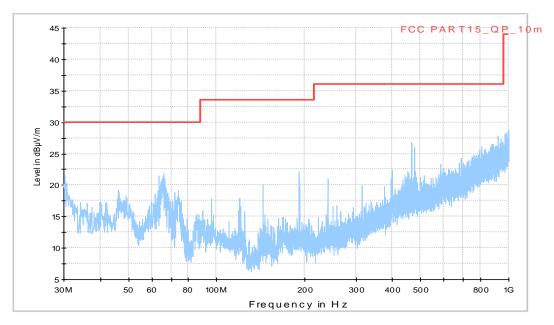
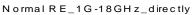


Figure A.5 Radiated Emission from 30MHz to 1GHz



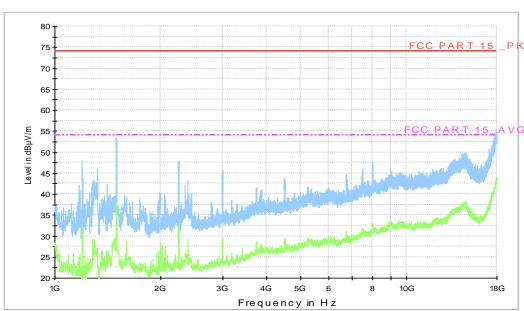


Figure A.6 Radiated Emission from 1GHz to 18GHz



#### A.2 Conducted Emission

#### Reference

FCC: CFR Part 15.107(a). IC: ICES-003 Section 5.

#### A.2.1 Method of measurement

For equipment that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies within the band 150 kHz to 30 MHz shall not exceed the limits. Tested in accordance with the procedures of ANSI C63.4 – 2014, section 7.3.

#### A.2.2 EUT Operating Mode

The MS is operating in the charging mode. During the test MS is connected to a charger in the case of charging mode.

#### A.2.3 Measurement Limit

Frequency of emission (MHz)	Conducted limit (dBµV)					
	Quasi-peak Average					
0.15-0.5	66 to 56*	56 to 46*				
0.5-5	56	46				
5-30 60 50						
*Decreases with the logarithm of the frequency						

#### A.2.4 Test Condition in charging mode

Voltage (V)	Frequency (Hz)
120	60

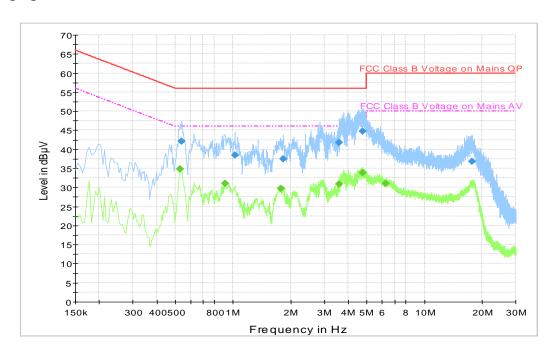
RBW/IF bandwidth	Sweep Time(s)
9kHz	1



#### A.2.5 Measurement Results

Measurement uncertainty: U= 3.38 dB, k=2.

Charging Mode, Set.17



**Figure A.7 Conducted Emission** 

#### **Final Result 1**

Frequency	QuasiPeak	Meas.	Bandwidth	Filter	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	Time	(kHz)			(dB)	(dB)	(dBµV)
		(ms)						
0.537000	42.1	2000.0	9.000	On	L1	19.9	13.9	56.0
1.023000	38.5	2000.0	9.000	On	L1	19.8	17.5	56.0
1.824000	37.4	2000.0	9.000	On	L1	19.7	18.6	56.0
3.597000	41.8	2000.0	9.000	On	L1	19.7	14.2	56.0
4.776000	44.7	2000.0	9.000	On	L1	19.7	11.3	56.0
17.763000	36.8	2000.0	9.000	On	L1	19.9	23.2	60.0

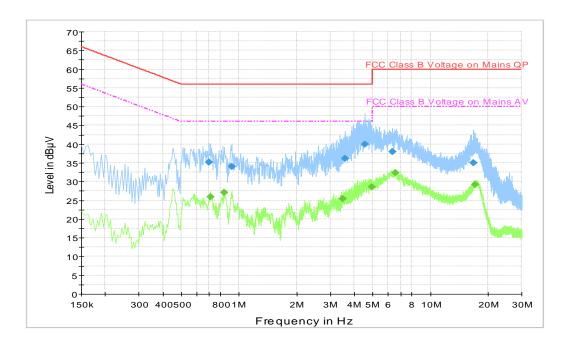
### Final Result 2

Frequency	CAverage	Meas.	Bandwidth	Filter	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	Time	(kHz)			(dB)	(dB)	(dBµV)
		(ms)						
0.528000	34.8	2000.0	9.000	On	L1	19.9	11.2	46.0
0.910500	31.0	2000.0	9.000	On	L1	19.8	15.0	46.0
1.774500	29.8	2000.0	9.000	On	L1	19.7	16.2	46.0
3.588000	30.9	2000.0	9.000	On	L1	19.7	15.1	46.0
4.776000	33.9	2000.0	9.000	On	L1	19.7	12.1	46.0
6.301500	31.1	2000.0	9.000	On	N	19.8	18.9	50.0

Note: The measurement results showed here are worst cases of the combinations of different batteries and USB cables.



#### **Charging Mode, Set.23**



**Figure A.8 Conducted Emission** 

#### **Final Result 1**

i iiiai ites	ait i							
Frequency	QuasiPeak	Meas.	Bandwidth	Filter	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	Time	(kHz)			(dB)	(dB)	(dBµV)
		(ms)						
0.694500	35.2	2000.0	9.000	On	L1	19.9	20.8	56.0
0.915000	34.0	2000.0	9.000	On	L1	19.8	22.0	56.0
3.574500	36.2	2000.0	9.000	On	L1	19.7	19.8	56.0
4.537500	39.9	2000.0	9.000	On	L1	19.7	16.1	56.0
6.328500	37.9	2000.0	9.000	On	L1	19.8	22.1	60.0
16.836000	34.9	2000.0	9.000	On	N	19.9	25.1	60.0

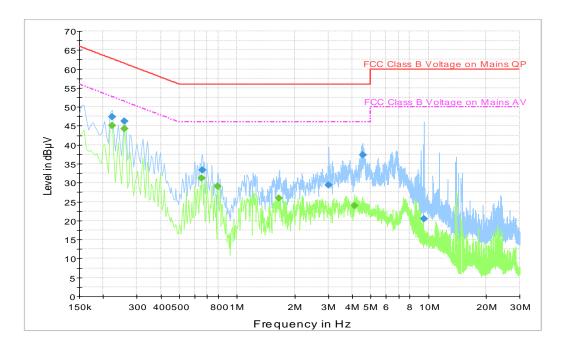
#### **Final Result 2**

i iiiai itcs	uit Z							
Frequency	CAverage	Meas.	Bandwidth	Filter	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	Time	(kHz)			(dB)	(dB)	(dBµV)
		(ms)						
0.708000	25.9	2000.0	9.000	On	L1	19.9	20.1	46.0
0.834000	27.0	2000.0	9.000	On	L1	19.8	19.0	46.0
3.493500	25.4	2000.0	9.000	On	L1	19.7	20.6	46.0
4.924500	28.6	2000.0	9.000	On	N	19.7	17.4	46.0
6.589500	32.3	2000.0	9.000	On	L1	19.8	17.7	50.0
17.155500	29.2	2000.0	9.000	On	L1	19.9	20.8	50.0

Note: The measurement results showed here are worst cases of the combinations of different batteries and USB cables.



#### **USB Mode, Set.25**



**Figure A.9 Conducted Emission** 

#### **Final Result 1**

i iiiai itoo	ait i							
Frequency	QuasiPeak	Meas.	Bandwidth	Filter	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	Time	(kHz)			(dB)	(dB)	(dBµV)
		(ms)						
0.222000	47.4	2000.0	9.000	On	N	19.8	15.3	62.7
0.258000	46.2	2000.0	9.000	On	N	19.8	15.3	61.5
0.658500	33.4	2000.0	9.000	On	N	19.9	22.6	56.0
3.021000	29.5	2000.0	9.000	On	L1	19.7	26.5	56.0
4.533000	37.4	2000.0	9.000	On	L1	19.7	18.6	56.0
9.487500	20.4	2000.0	9.000	On	L1	19.9	39.6	60.0

### Final Result 2

Frequency	CAverage	Meas.	Bandwidth	Filter	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	Time	(kHz)			(dB)	(dB)	(dBµV)
		(ms)						
0.222000	45.1	2000.0	9.000	On	N	19.8	7.6	52.7
0.258000	44.3	2000.0	9.000	On	N	19.8	7.2	51.5
0.654000	31.2	2000.0	9.000	On	N	19.9	14.8	46.0
0.793500	29.0	2000.0	9.000	On	N	19.8	17.0	46.0
1.662000	25.9	2000.0	9.000	On	N	19.7	20.1	46.0
4.114500	24.0	2000.0	9.000	On	N	19.7	22.0	46.0

Note: The measurement results showed here are worst cases of the combinations of different batteries and USB cables.



# United States Department of Commerce National Institute of Standards and Technology



## Certificate of Accreditation to ISO/IEC 17025:2005

**NVLAP LAB CODE: 600118-0** 

#### Telecommunication Technology Labs, CAICT

Beijing China

is accredited by the National Voluntary Laboratory Accreditation Program for specific services, listed on the Scope of Accreditation, for:

#### **Electromagnetic Compatibility & Telecommunications**

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005.

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communique dated January 2009).

2016-09-29 through 2017-09-30

Effective Dates



For the National Voluntary Laboratory Accreditation Program

\*\*\*END OF REPORT\*\*\*